

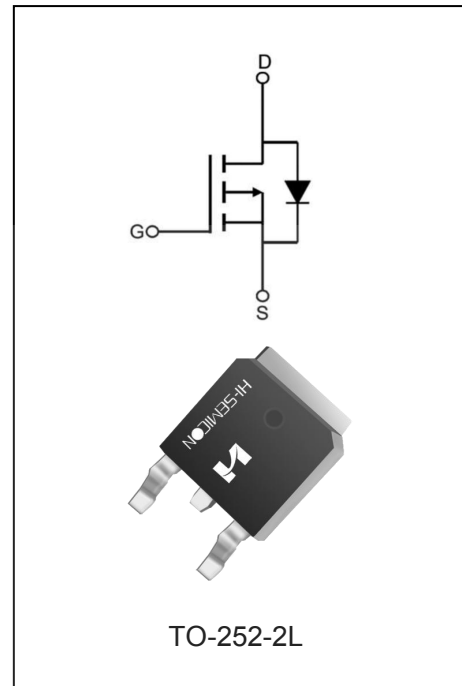
**-15A, -40V P-CHANNEL MOSFET**

**GENERAL DESCRIPTION**

The SFD4001PT5 uses advanced trench technology and design to provide excellent  $R_{DS(on)}$  with low gate charge. It can be used in a wide variety of applications. Such as: PWM Applications, Power Management

**FEATURES**

- ◆  $R_{DS(on)}=28.9m\Omega(Typ)@V_{GS}=-10V, I_D=-3A$
- ◆  $R_{DS(on)}=38.2m\Omega(Typ)@V_{GS}=-4.5V, I_D=-3A$
- ◆  $V_{DS}=-40V, I_D=-15A$
- ◆ Advance Trench Technology
- ◆ Fast Switching and High Efficiency
- ◆ Lead Free and Green Devices Available: Rohs Compliant



TO-252-2L

**ORDERING INFORMATION**

Part No.	Package	Marking	Material	Packing
SFD4001PT5	TO-252-2L	SFD4001PT5	Pb Free	Reel

## ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C unless otherwise noted)

Characteristics		Symbol	Ratings	Unit
Drain-Source Voltage		V <sub>DS</sub>	-40	V
Gate-Source Voltage		V <sub>GS</sub>	±20	V
Drain Current	T <sub>C</sub> = 25°C	I <sub>D</sub>	-15	A
	T <sub>C</sub> = 100°C		-12	
Drain Current Pulsed(Note 1)		I <sub>DM</sub>	-60	A
Power Dissipation(T <sub>C</sub> =25°C)		P <sub>D</sub>	3.5	W
Operation Junction Temperature Range		T <sub>J</sub>	-55~+175	°C
Storage Temperature Range		T <sub>stg</sub>	-55~+175	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		TL	300	°C

## THERMAL CHARACTERISTICS

Characteristics	Symbol	MAX	Unit
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	12	°C/W
Thermal Resistance, Junction-to-Ambient	R <sub>θJA</sub>	62.5	°C/W

## ELECTRICAL CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
<b>Off Characteristics</b>						
Drain -Source Breakdown Voltage	B <sub>VDS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	40	44.1	-	V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =-40V, V <sub>GS</sub> =0V	-	-9.1	-80	nA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	2.8	100	nA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V	-	-1.2	-100	nA
<b>On Characteristics</b>						
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> =-250μA	-1.3	-1.6	-2.1	V
Static Drain- Source On State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-3A	-	28.9	34	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A	-	38.2	47	mΩ
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =-20V V <sub>GS</sub> =0V f=1.0MHZ	-	910	-	pF
Output Capacitance	C <sub>oss</sub>		-	92	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	70	-	
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =-20V, V <sub>GS</sub> =-10V R <sub>G</sub> =3Ω, I <sub>D</sub> =5A (Note 2.3)	-	9	-	ns
Turn-on Rise Time	t <sub>r</sub>		-	15	-	
Turn-off Delay Time	t <sub>d(off)</sub>		-	46	-	
Turn-off Fall Time	t <sub>f</sub>		-	70	-	
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =-20V, I <sub>D</sub> =-15A V <sub>GS</sub> =-10V (Note 2.3)	-	12	-	nC
Gate-Source Charge	Q <sub>gs</sub>		-	5.2	-	

Gate-Drain Charge	$Q_{gd}$	$V_{DS}=-20V, I_D=-15A$ $V_{GS}=-10V$ (Note 2.3)	-	4.5	-	nC
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**SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS**

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	$I_S$	Integral Reverse P-N Junction Diode in the MOSFET	-	-	-15	A
Pulsed Source Current	$I_{SM}$		-	-	-60	
Diode Forward Voltage	$V_{SD}$	$I_S=-5A, V_{GS}=0V$	-	-0.8	-1.3	V

**Notes:**

- 1.Pulse width limited by maximum junction temperature
- 2.Pulse Test: Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$
- 3.Essentially independent of operating temperature

Typical Performance Characteristics

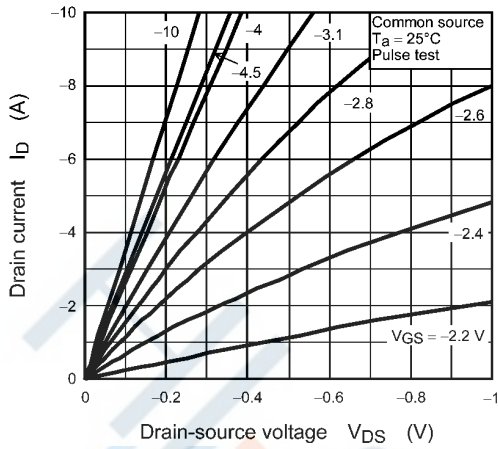


Figure.1 ID - VDS

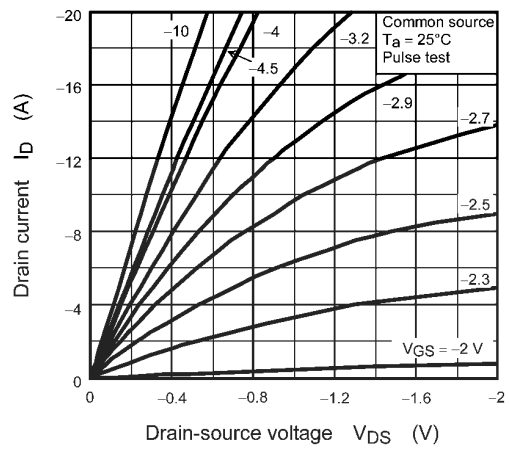


Figure.2 ID - VDS

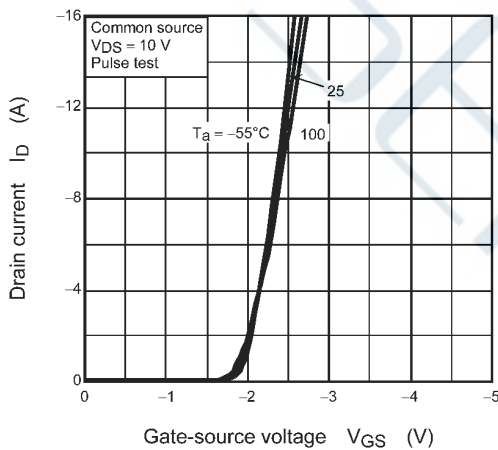


Figure.3 VDS-VGS

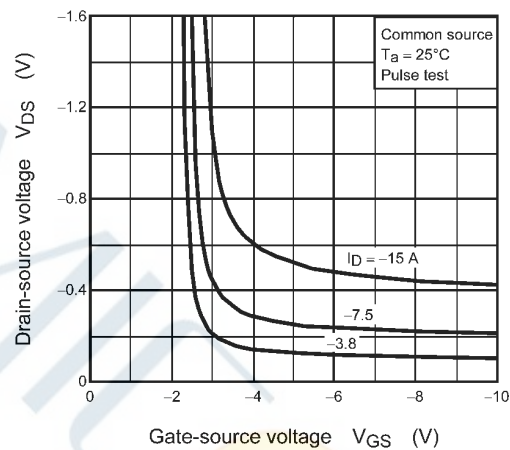


Figure.4 VDS-VGS

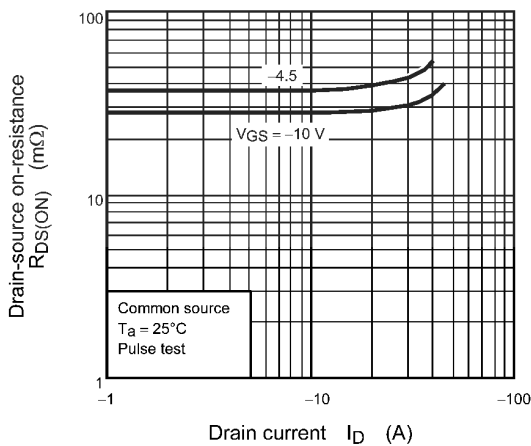


Figure.5 RDS(ON) -  $I_D$

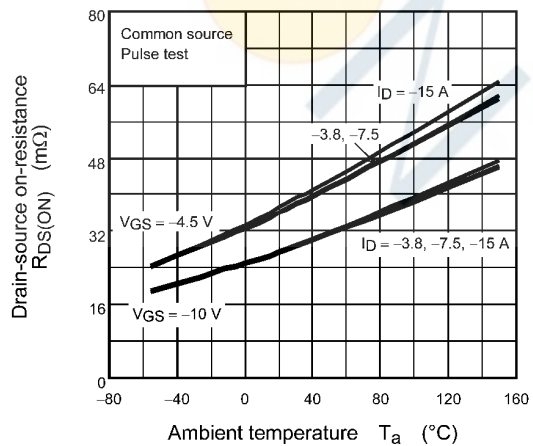


Figure.6 RDS(ON) -  $T_a$

Typical Performance Characteristics

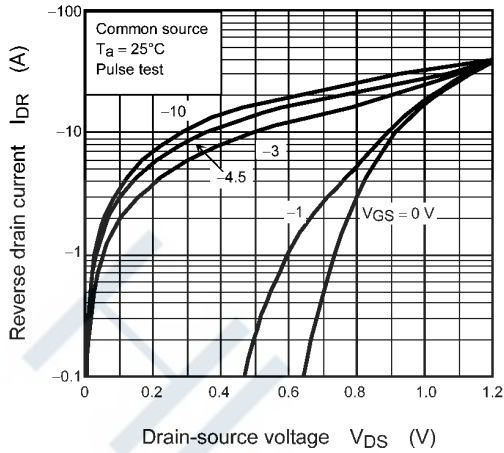


Figure.7 IDR - VDS

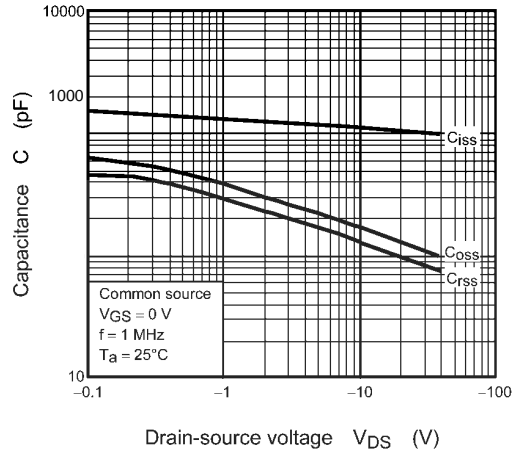


Figure.8 Capacitance - VDS

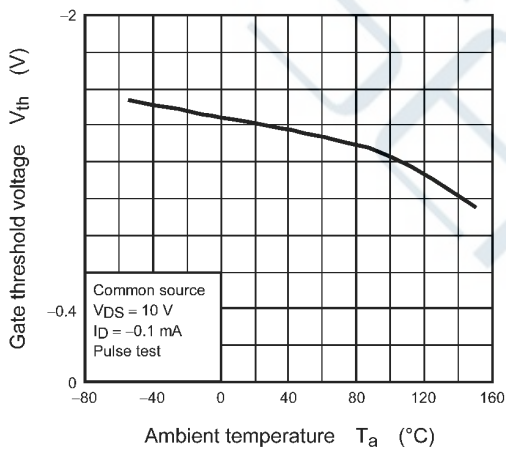


Figure.9 Vth - Ta

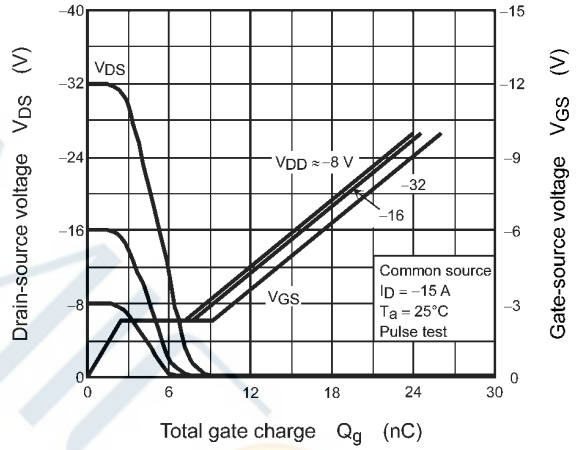


Figure.10 Dynamic Input/Out Characteristics

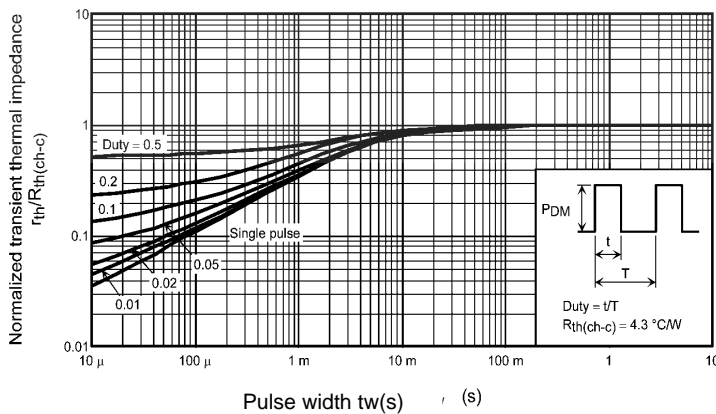


Figure.11 Zth(ch-c) - tw

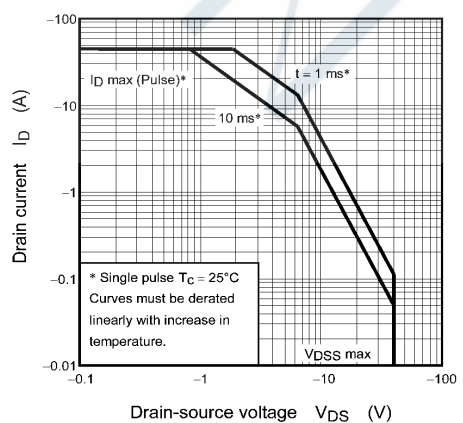
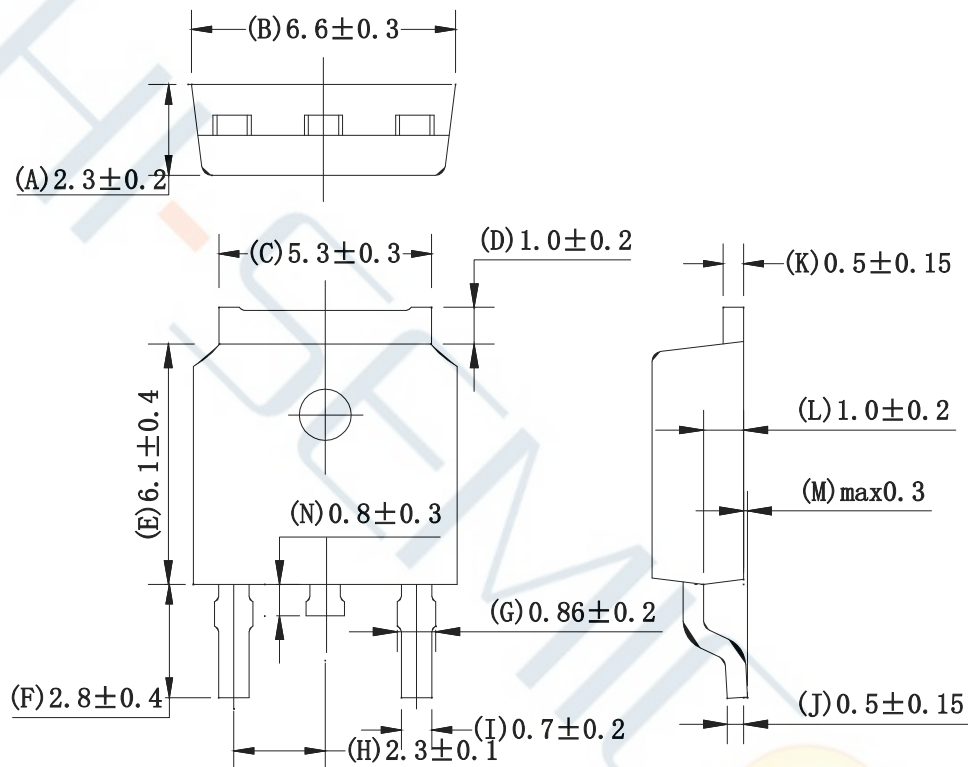


Figure.12 Safe Operating Area

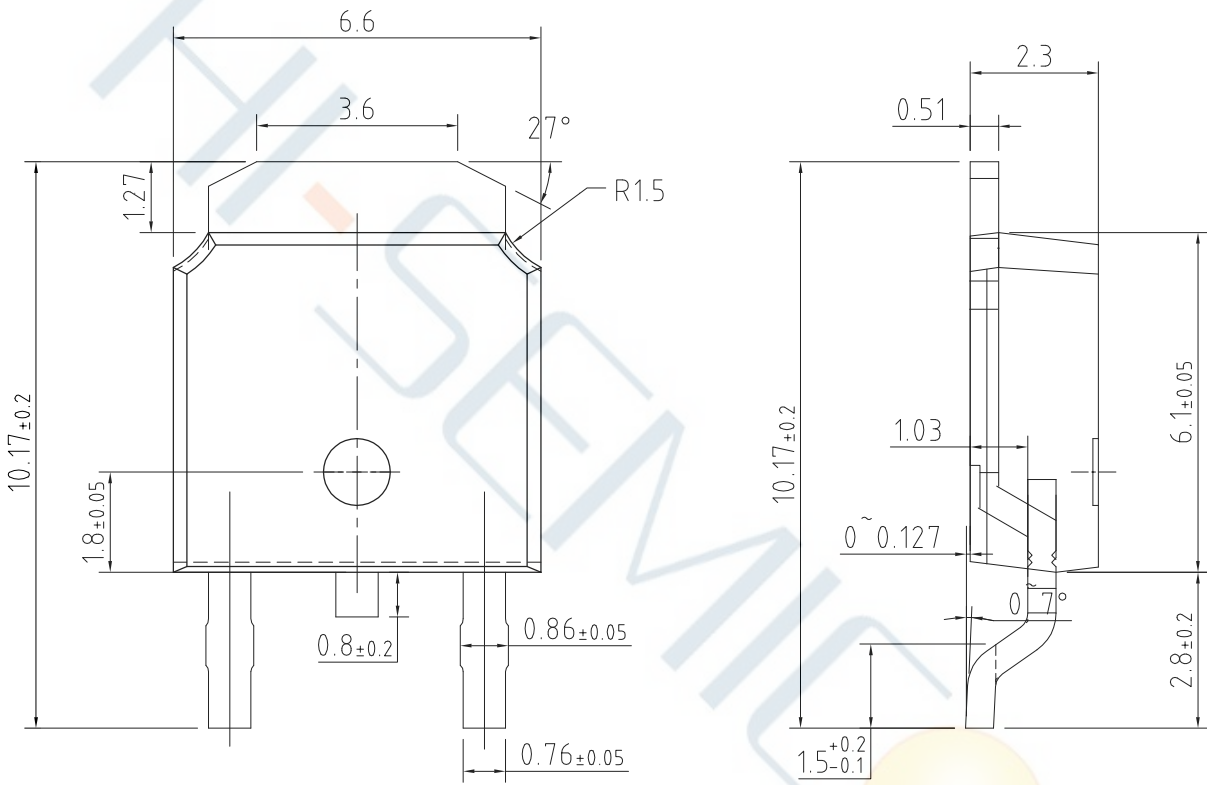
Package Dimensions of TO-252-2L

Unit:mm



Package Dimensions of TO-252-2L

Unit:mm



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